## Notice of References Cited

Applica 10/664	ation/Control No. ,743	Applicant(s)/Patent Under Reexamination HELMREICH ET AL.		
Exami	ner	Art Unit		
Leonid	M Fastovsky	3742	Page 1 of 1	

## **U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	А	US-6,710,313	03-2004	Asami et al.	219/549
	В	US-2003/0218003	11-2003	Ellis et al.	219/528
	С	US-6,593,555	07-2003	Hayashi, Yukiko	219/553
	D	US-6,563,094	05-2003	Kochman et al.	219/549
	E	US-6,550,471	04-2003	Szymocha et al.	126/208
	F	US-5,925,275	07-1999	Lawson et al.	219/543
	G	US-4,074,222	02-1978	Kiyokawa et al.	338/212
	Н	US-6,229,123	05-2001	Kochman et al.	219/549
	ı	US-3,859,504	01-1975	Motokawa et al.	219/528
	J	US-6,653,607	11-2003	Ellis et al.	219/528
	К	US-5,138,138	08-1992	Theilacker et al.	219/528
	L	US-			
	М	US-			

## FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N	JP2002367798	12-2002	Japan	Shimadzu	H05G 1/26
	0	JP403066370	03-1991	Japan	Saito	A61F 7/00
	Р	*				
	Q					
	R					
	s					
	Т					

## **NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	w	
	Х	

\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).) Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.